Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/981,688	TANSKANEN ET AL.	
Examiner	Art Unit	
X. L. Bautista	2179	

	SEARCHED				
Class	Subclass	Date	Examiner		
same as	prior search	12/24/2006	ХВ		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEAR (INCLUDING S	RCH NOTES EARCH ST		)
		DATE	EXMR
EAST Search	. 1	2/24/2006	ХВ
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